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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

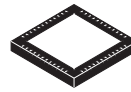
Applications of "[Embedded - Microcontrollers](#)"

Details

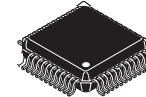
Product Status	Active
Core Processor	RS08
Core Size	8-Bit
Speed	20MHz
Connectivity	SCI, SPI
Peripherals	LCD, LVD, POR, PWM, WDT
Number of I/O	31
Program Memory Size	8KB (8K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	256 x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 6x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	48-VQFN Exposed Pad
Supplier Device Package	48-QFN-EP (7x7)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mc9rs08la8cft



MC9RS08LA8



48 QFN
Case 1975
7 mm²



48 LQFP
Case 932
7 mm²

MC9RS08LA8

Features:

- 8-Bit RS08 Central Processor Unit (CPU)
 - Up to 20 MHz CPU at 2.7 V to 5.5 V across temperature range of –40°C to 85°C
 - Subset of HC08 instruction set with added BGND instruction
- On-Chip Memory
 - 8 KB flash read/program/erase over full operating voltage and temperature
 - 256-byte random-access memory (RAM)
 - Security circuitry to prevent unauthorized access to flash contents
- Power-Saving Modes
 - Wait and stop
- Clock Source Options
 - Oscillator (XOSC) — Loop-control Pierce oscillator; crystal or ceramic resonator range of 31.25 kHz to 39.0625 kHz or 1 MHz to 16 MHz
 - Internal clock source (ICS) — Internal clock source module containing a frequency-locked-loop (FLL) controlled by internal or external reference; supports bus frequencies up to 10 MHz
- System Protection
 - Watchdog computer operating properly (COP) reset with option to run from dedicated 1 kHz internal clock source or bus clock
 - Low-voltage detection with reset or interrupt; selectable trip points
 - Illegal opcode detection with reset
 - Illegal address detection with reset
 - Flash block protection
- Development Support
 - Single-wire background debug interface
 - Breakpoint capability to allow single breakpoint setting during in-circuit debugging
- Peripherals
 - **LCD** — Up to 8 × 21 or 4 × 25 segments; compatible with 5 V or 3 V LCD glass displays using on-chip charge pump; functional in wait, stop modes for very low power LCD operation; frontplane and backplane pins multiplexed with GPIO functions; selectable frontplane and backplane configurations
 - **ADC** — 6-channel, 10-bit resolution; 2.5 μs conversion time; automatic compare function; 1.7 mV/°C temperature sensor; internal bandgap reference channel; operation in stop; fully functional from 2.7 V to 5.5 V.
 - **TPM** — One 2-channel 16-bit timer/pulse-width modulator (TPM) module
 - **SCI** — One 2-channel serial communications interface module with optional 13-bit break; LIN extensions
 - **SPI** — One serial peripheral interface module in 8-bit data length mode with a receive data buffer hardware match function
 - **ACMP** — Analog comparator with option to compare to internal reference
 - **MTIM** — One 8-bit modulo timer
 - **KBI** — 8-pin keyboard interrupt module
 - **RTI** — One real-time interrupt module with optional reference clock.
- Input/Output
 - 33 GPIOs including 1 output only pin and 1 input only pin.
 - Hysteresis and configurable pullup device on all input pins; configurable slew rate and drive strength on all output pins.
- Package Options
 - 48-pin QFN
 - 48-pin LQFP

This document contains information on a product under development. Freescale reserves the right to change or discontinue this product without notice.

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Revision History

To provide the most up-to-date information, the revision of our documents on the World Wide Web will be the most current. Your printed copy may be an earlier revision. To verify you have the latest information available, refer to:

<http://freescale.com/>

The following revision history table summarizes changes contained in this document.

Revision	Date	Description of Changes
1	10/9/2008	Initial public released.
2	1/30/2012	Updated the case number of 48-pin QFN to 1975; updated 48-pin QFN case outline drawing.

Related Documentation

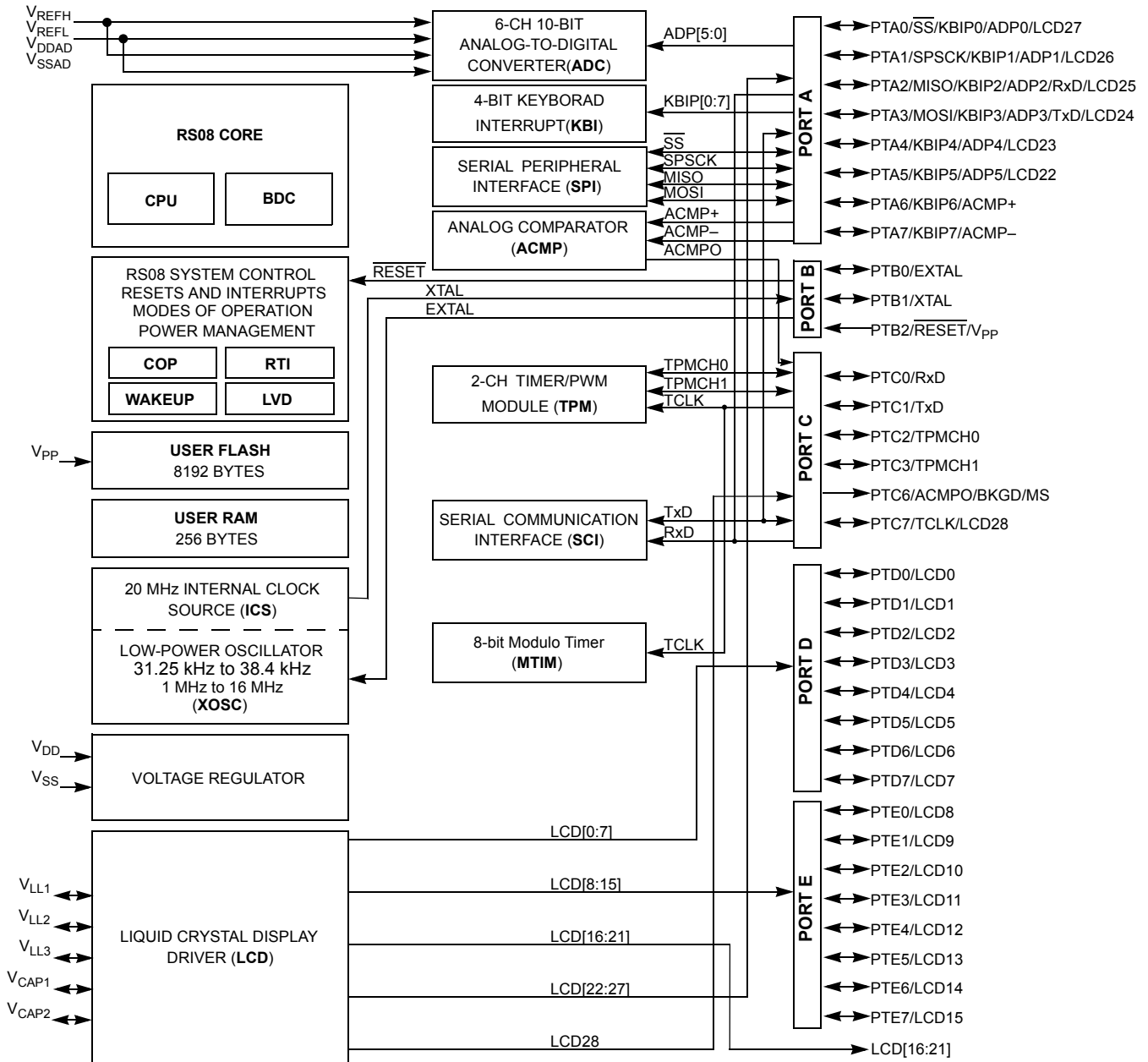
Find the most current versions of all documents at: <http://www.freescale.com>

Reference Manual (MC9RS08LA8RM)

Contains extensive product information including modes of operation, memory, resets and interrupts, register definition, port pins, CPU, and all module information.

1 MCU Block Diagram

The block diagram, [Figure 1](#), shows the structure of the MC9RS08LA8 MCU.



NOTES:

1. $\overline{PTB2}/\overline{RESET}/V_{PP}$ is an input only pin when used as port pin
2. PTC6/ACMPO/BKGD/MS is an output only pin

Figure 1. MC9RS08LA8 Series Block Diagram

Table 1. Pin Availability by Package Pin-Count (continued)

Pin Number	<-- Lowest Priority --> Highest					
	Port Pin	Alt 1	Alt 2	Alt 3	Alt 4	Alt 5
32	PTA3	MOSI	KBIP3	TxD	ADP3	LCD24
33	PTA4		KBIP4	ADP4		LCD23
34	PTA5		KBIP5	ADP5		LCD22
35						LCD21
36						LCD20
37						LCD19
38						LCD18
39						LCD17
40						LCD16
41	PTE7					LCD15
42	PTE6					LCD14
43	PTE5					LCD13
44	PTE4					LCD12
45	PTE3					LCD11
46	PTE2					LCD10
47	PTE1					LCD9
48	PTE0					LCD8

3 Electrical Characteristics

This chapter contains electrical and timing specifications.

3.1 Parameter Classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding the following classification is used and the parameters are tagged accordingly in the tables where appropriate:

Table 2. Parameter Classifications

P	Those parameters are guaranteed during production testing on each individual device.
C	Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations.
T	Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category.
D	Those parameters are derived mainly from simulations.

NOTE

The classification is shown in the column labeled “C” in the parameter tables where appropriate.

3.2 Absolute Maximum Ratings

Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond the limits specified in [Table 3](#) may affect device reliability or cause permanent damage to the device. For functional operating conditions, refer to the remaining tables in this chapter.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (for instance, either V_{SS} or V_{DD}) or the programmable pull-up resistor associated with the pin is enabled.

Table 3. Absolute Maximum Ratings

Rating	Symbol	Value	Unit
Supply voltage	V_{DD}	2.7 to 5.5	V
Maximum current into V_{DD}	I_{DD}	120	mA
Digital input voltage	V_{In}	-0.3 to $V_{DD} + 0.3$	V
Instantaneous maximum current Single pin limit (applies to all port pins) ^{1, 2, 3}	I_D	± 25	mA
Storage temperature range	T_{stg}	-55 to 150	°C

Electrical Characteristics

- 1 Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive (V_{DD}) and negative (V_{SS}) clamp voltages, then use the larger of the two resistance values.
- 2 All functional non-supply pins are internally clamped to V_{SS} and V_{DD} except the $\overline{\text{RESET}}/V_{PP}$ pin which is internally clamped to V_{SS} only.
- 3 Power supply must maintain regulation within operating V_{DD} range during instantaneous and operating maximum current conditions. If positive injection current ($V_{in} > V_{DD}$) is greater than I_{DD} , the injection current may flow out of V_{DD} and could result in external power supply going out of regulation. Ensure external V_{DD} load will shunt current greater than maximum injection current. This will be the greatest risk when the MCU is not consuming power. Examples are: if no system clock is present, or if the clock rate is very low which would reduce overall power consumption.

3.3 Thermal Characteristics

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and voltage regulator circuits and it is user-determined rather than being controlled by the MCU design. In order to take $P_{I/O}$ into account in power calculations, determine the difference between actual pin voltage and V_{SS} or V_{DD} and multiply by the pin current for each I/O pin. Except in cases of unusually high pin current (heavy loads), the difference between pin voltage and V_{SS} or V_{DD} will be very small.

Table 4. Thermal Characteristics

Rating	Symbol	Value	Unit	
Operating temperature range (packaged)	T_A	T_L to T_H -40 to 85	$^{\circ}\text{C}$	
Maximum junction temperature	T_{JMAX}	105	$^{\circ}\text{C}$	
Thermal resistance				
Single layer board				
48-pin LQFP	θ_{JA}	71	$^{\circ}\text{C}/\text{W}$	
48-pin QFN		84		
Four layer board				
48-pin LQFP		49		
48-pin QFN		28		

The average chip-junction temperature (T_J) in $^{\circ}\text{C}$ can be obtained from:

$$T_J = T_A + (P_D \times \theta_{JA}) \quad \text{Eqn. 1}$$

where:

T_A = Ambient temperature, $^{\circ}\text{C}$

θ_{JA} = Package thermal resistance, junction-to-ambient, $^{\circ}\text{C}/\text{W}$

$P_D = P_{int} + P_{I/O}$

$P_{int} = I_{DD} \times V_{DD}$, Watts chip internal power

$P_{I/O}$ = Power dissipation on input and output pins user determined

For most applications, $P_{I/O} \ll P_{int}$ and can be neglected. An approximate relationship between P_D and T_J

Table 7. DC Characteristics (Temperature Range = -40 to 85°C Ambient) (continued)

Num	C	Parameter	Symbol	Min	Typical	Max	Unit
15	P	Output low voltage (port A) ⁴ $I_{OL} = 5 \text{ mA}$ ($V_{DD} \geq 4.5 \text{ V}$) $I_{OL} = 3 \text{ mA}$ ($V_{DD} \geq 3 \text{ V}$)	V_{OL}	—	—	0.8 0.8	V
16	C	Maximum total IOL for all port pins	I_{OLT}	—	—	100	mA
17	C	dc injection current ^{5,6,7} $V_{In} < V_{SS}$, $V_{In} > V_{DD}$ Single pin limit Total MCU limit, includes sum of all stressed pins		— —	— —	0.2 0.8	mA mA
18	C	Input capacitance (all non-supply pins)	C_{In}	—	—	7	pF

¹ This parameter is characterized and not tested on each device.

² Measurement condition for pull resistors: $V_{In} = V_{SS}$ for pullup and $V_{In} = V_{DD}$ for pulldown.

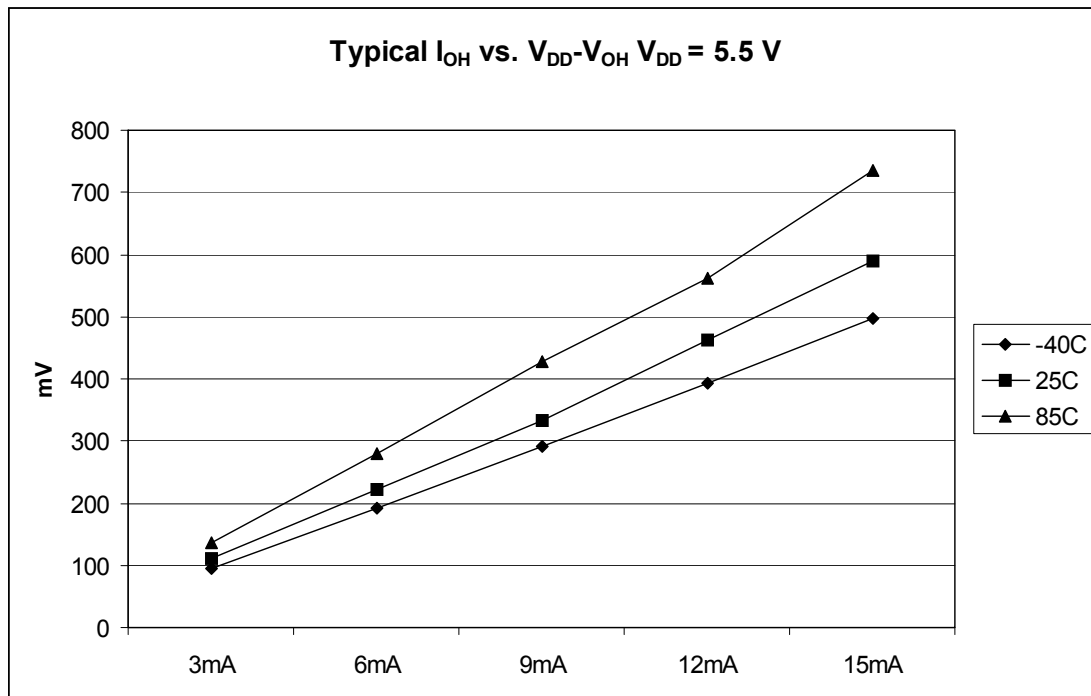
³ The I_{OH} is for high output drive strength.

⁴ It is tested under high output drive strength only.

⁵ All functional non-supply pins are internally clamped to V_{SS} and V_{DD} except the $\overline{\text{RESET}}/V_{PP}$ which is internally clamped to V_{SS} only

⁶ Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

⁷ This parameter is characterized and not tested on each device.


Figure 3. Typical I_{OH} vs. $V_{DD}-V_{OH}$ ($V_{DD} = 5.5 \text{ V}$)

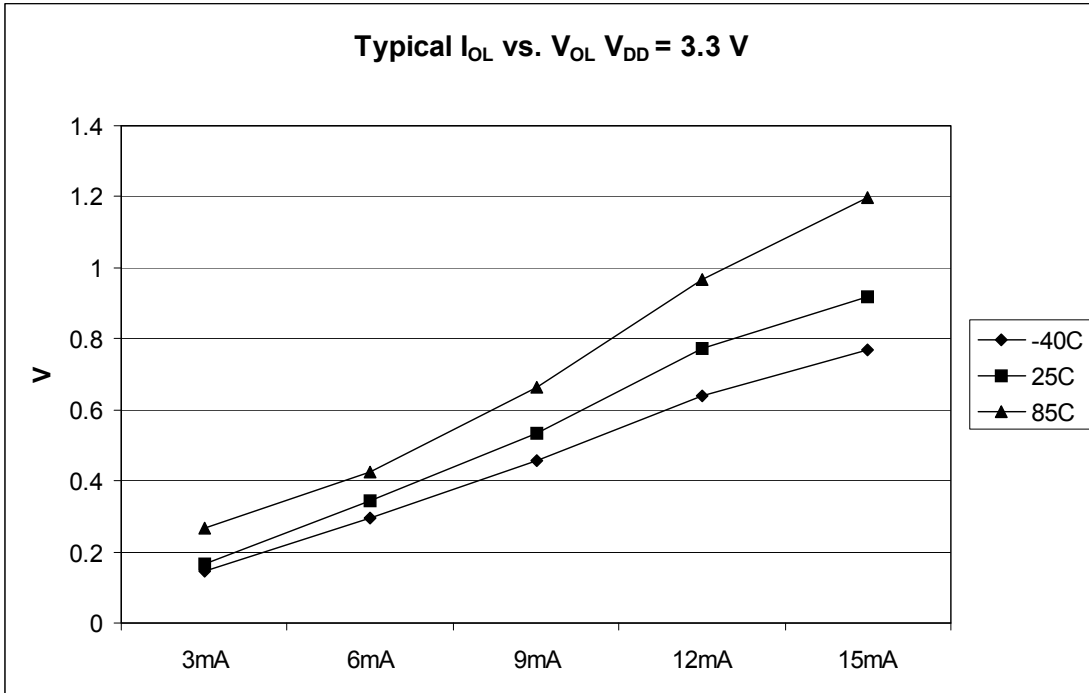


Figure 6. Typical I_{OL} vs. V_{OL} ($V_{DD} = 3.3\text{ V}$)

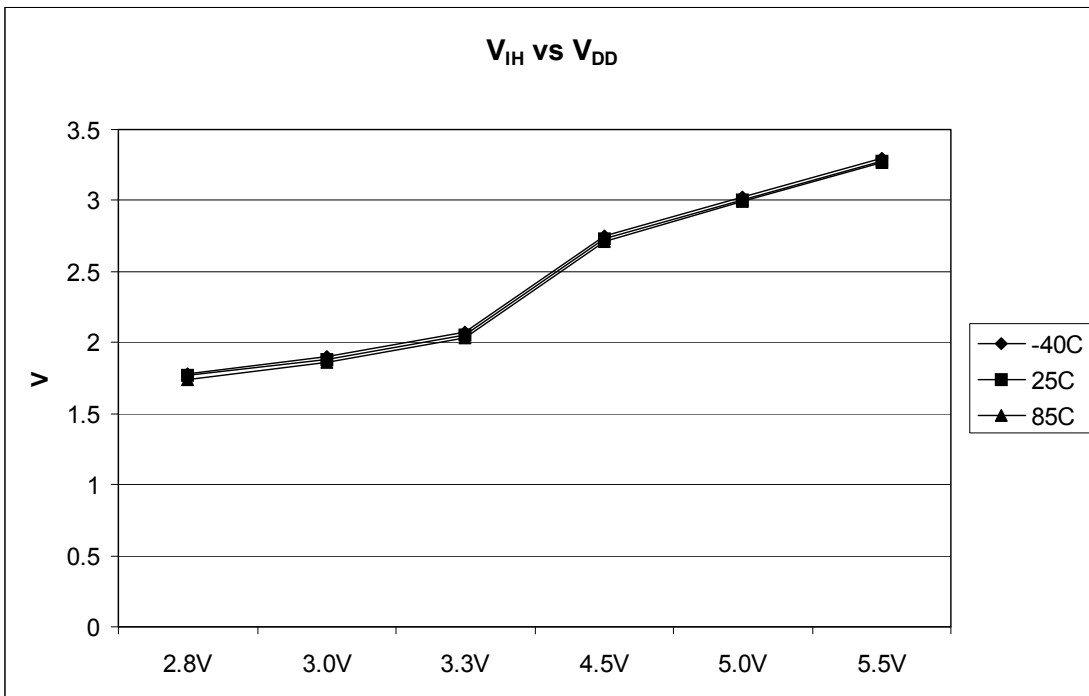


Figure 7. Typical V_{DD} vs. V_{IH}

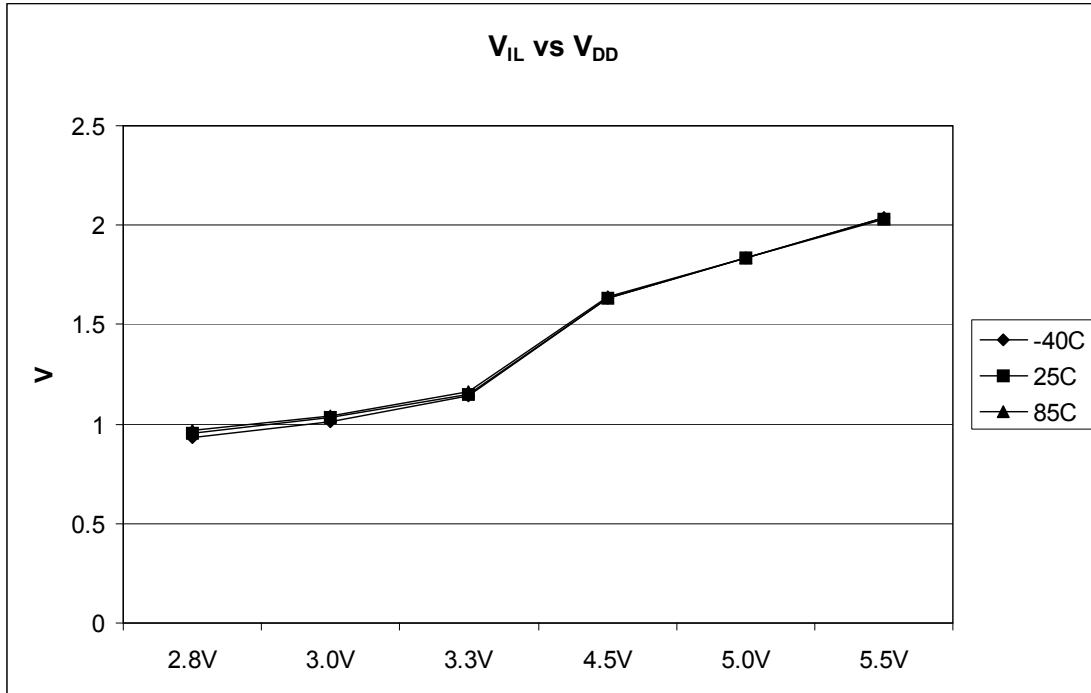


Figure 8. Typical V_{DD} vs. V_{IL}

3.6 Supply Current Characteristics

Table 8. Supply Current Characteristics

Num	C	Parameter	Symbol	V_{DD} (V)	Typical ¹	Unit
1	P	Run supply current ² measured at ($f_{Bus} = 10$ MHz)	$R_{I_{DD10}}$	5	3.71	mA
				3.3	3.68	mA
				3	3.67	mA
				2.7	3.66	mA
2	P	Wait mode supply current	$W_{I_{DD1}}$	5	1.37	mA
				3.3	1.37	mA
				3	1.37	mA
				2.7	1.36	mA
3	P	Stop mode supply current	$S_{I_{DD}}$	5	1.40	μ A
				3.3	1.35	μ A
				3	1.31	μ A
				2.7	1.25	μ A
4	C	ADC adder from stop ³	—	5	125.45	μ A
				3.3	122.04	μ A
				3	121.59	μ A
				2.7	121.22	μ A
5	C	ACMP adder from stop (ACME = 1)	—	5	21	μ A
				3	18.5	μ A

Table 9. External Oscillator Specifications (Temperature Range = –40 to 85°C Ambient)

Characteristic	Symbol	Min	Typical ¹	Max	Unit
Oscillator crystal or resonator (EREFS = 1)					
Low range, (IREFS = x)	f_{lo}	32	—	38.4	kHz
High range, FLL bypassed external (CLKS = 10, IREFS = x)	f_{hi_byp}	1	—	10	MHz
High range, FLL engaged external (CLKS = 00, IREFS = 0)	f_{hi_eng}	1	—	10	MHz
Load capacitors	C_1 C_2	See Note ²			
Feedback resistor					
Low range (32 kHz to 100 kHz)	R_F		10		MΩ
High range (1 MHz to 16 MHz)			1		MΩ
Series resistor					
Low range					
Low Gain (HGO = 0)		—	0	—	
High Gain (HGO = 1)		—	100	—	
High range					
Low Gain (HGO = 0)	R_S	—	0	—	kΩ
High Gain (HGO = 1)					
≥ 8 MHz		—	0	—	
4 MHz		—	10	—	
1 MHz		—	20	—	
Crystal start-up time ^{3, 4}					
Low range	t_{CSTL}	—	500	—	ms
High range	t_{CSTH}	—	4	—	
Square wave input clock frequency (EREFS = 0)					
FLL bypass external (CLKS = 10)	f_{extal}	0	—	20	MHz
FLL engaged external (CLKS = 00)		0.03125	—	5	
Average internal reference frequency - untrimmed	f_{int_ut}	25	31.25	41.66	kHz
Average internal reference frequency - trimmed	f_{int_t}	31.25	31.25	39.0625	kHz
DCO output frequency range - untrimmed	f_{dco_ut}	12.8	16	21.33	MHz
DCO output frequency range - trimmed	f_{dco_t}	16	16	20	MHz
Resolution of trimmed DCO output frequency at fixed voltage and temperature	$\Delta f_{dco_res_t}$	—	—	±0.2	% f_{dco}
Total deviation of trimmed DCO output frequency over voltage and temperature	Δf_{dco_t}	—	—	±2	% f_{dco}
FLL acquisition time ^{3,5}	$t_{acquire}$	—	—	1	ms
Long term Jitter ⁶ of DCO output clock (averaged over 2ms interval)	C_{jitter}	—	—	0.6	% f_{dco}

¹ Data in Typical column was characterized at 3.0 V, 25 °C or is typical recommended value.

² See crystal or resonator manufacturer's recommendation.

³ This parameter is characterized and not tested on each device.

⁴ Proper PC board layout procedures must be followed to achieve specifications.

⁵ This specification applies to any time the FLL reference source or reference divider is changed, trim value changed or changing from FLL disabled (FBELP, FBILP) to FLL enabled (FEI, FEE, FBE, FBI). If a crystal/resonator is being used as the reference, this specification assumes it is already running.

Electrical Characteristics

- ⁴ This parameter is characterized and not tested on each device.
- ⁵ This specification applies to any time the FLL reference source or reference divider is changed, trim value changed or changing from FLL disabled (FBILP) to FLL enabled (FEI, FBI).

3.11 ADC Characteristics

Table 14. 5 Volt 10-bit ADC Operating Conditions

Characteristic	Conditions	Symbol	Min	Typical ¹	Max	Unit
Supply voltage	Absolute	V_{DDAD}	2.7	—	5.5	V
	Delta to V_{DD} ($V_{DD} - V_{DDAD}$) ²	ΔV_{DDAD}	-100	0	100	mV
Ground voltage	Delta to V_{SS} ($V_{SS} - V_{SSAD}$) ²	ΔV_{SSAD}	-100	0	100	mV
Ref voltage high	—	V_{REFH}	2.7	V_{DDAD}	V_{DDAD}	V
Ref voltage low	—	V_{REFL}	V_{SSAD}	V_{SSAD}	V_{SSAD}	V
Input voltage	—	V_{ADIN}	V_{REFL}	—	V_{REFH}	V
Input capacitance	—	C_{ADIN}	—	4.5	5.5	pF
Input resistance	—	R_{ADIN}	—	3	5	k Ω
Analog source resistance external to MCU	10-bit mode $f_{ADCK} > 4\text{MHz}$ $f_{ADCK} < 4\text{MHz}$	R_{AS}	—	—	5	k Ω
	8-bit mode (all valid f_{ADCK})		—	—	10	
ADC conversion clock frequency	High speed (ADLPC = 0)	f_{ADCK}	0.4	—	8.0	MHz
	Low power (ADLPC = 1)		0.4	—	4.0	

¹ Typical values assume $V_{DDAD} = 5.0\text{ V}$, Temp = 25 °C, $f_{ADCK} = 1.0\text{ MHz}$ unless otherwise stated. Typical values are for reference only and are not tested in production.

² DC potential difference.

Table 15. 10-bit ADC Characteristics ($V_{REFH} = V_{DDAD}$, $V_{REFL} = V_{SSAD}$) (continued)

Characteristic	Conditions	C	Symbol	Min	Typical ¹	Max	Unit
Conversion time (Including sample time)	Short Sample (ADLSMP = 0)	P	t_{ADC}	—	20	—	ADCK cycles
	Long Sample (ADLSMP = 1)			—	40	—	
Sample time	Short Sample (ADLSMP = 0)	P	t_{ADS}	—	3.5	—	ADCK cycles
	Long Sample (ADLSMP = 1)			—	23.5	—	
Total unadjusted error	10-bit mode	P	E_{TUE}	—	± 1	± 2.5	LSB ²
	8-bit mode			—	± 0.5	± 1.0	
Differential non-linearity	10-bit mode	P	DNL	—	± 0.5	± 1.0	LSB ²
	8-bit mode			—	± 0.3	± 0.5	
	Monotonicity and no-missing-code guaranteed						
Integral non-linearity	10-bit mode	C	INL	—	± 0.5	± 1.0	LSB ²
	8-bit mode			—	± 0.3	± 0.5	
Zero-scale error	10-bit mode	P	E_{ZS}	—	± 0.5	± 1.5	LSB ²
	8-bit mode			—	± 0.5	± 0.5	
Full-scale error $V_{ADIN} = V_{DDA}$	10-bit mode	P	E_{FS}	—	± 0.5	± 1.5	LSB ²
	8-bit mode			—	± 0.5	± 0.5	
Quantization error	10-bit mode	D	E_Q	—	—	± 0.5	LSB ²
	8-bit mode			—	—	± 0.5	
Input leakage error pad leakage ³ * RAS	10-bit mode	D	E_{IL}	—	± 0.2	± 2.5	LSB ²
	8-bit mode			—	± 0.1	± 1	

¹ Typical values assume $V_{DDAD} = 5.0$ V, Temp = 25 °C, $f_{ADCK} = 1.0$ MHz unless otherwise stated. Typical values are for reference only and are not tested in production.

² 1 LSB = $(V_{REFH} - V_{REFL})/2^N$

³ Based on input pad leakage current. Refer to pad electrical.

3.12 AC Characteristics

This section describes AC timing characteristics for each peripheral system.

3.12.1 Control Timing

Table 16. Control Timing

Characteristic	Symbol	Min	Typical	Max	Unit
Bus frequency ($t_{cyc} = 1/f_{Bus}$)	f_{Bus}	DC	—	10	MHz
Real time interrupt internal oscillator period	t_{RTI}	700	1000	1300	μ s

Table 17. Flash Characteristics (continued)

Characteristic	Symbol	Min	Typical ¹	Max	Unit
Byte program time	t_{prog}	20	—	40	μ s
Mass erase time	t_{me}	500	—	—	ms
Cumulative program HV time ²	t_{hv}	—	—	8	ms
Total cumulative HV time (total of t_{me} & t_{hv} applied to device)	t_{hv_total}	—	—	2	hours
HVEN to program setup time	t_{pgs}	10	—	—	μ s
PGM/MASS to HVEN setup time	t_{nvs}	5	—	—	μ s
HVEN hold time for PGM	t_{nh}	5	—	—	μ s
HVEN hold time for MASS	t_{nh1}	100	—	—	μ s
V_{PP} to PGM/MASS setup time	t_{vps}	20	—	—	ns
HVEN to V_{PP} hold time	t_{vph}	20	—	—	ns
V_{PP} rise time ³	t_{vrs}	200	—	—	ns
Recovery time	t_{rcv}	1	—	—	μ s
Program/erase endurance T_L to $T_H = -40\text{ }^\circ\text{C}$ to $85\text{ }^\circ\text{C}$	—	1000	—	—	cycles
Data retention	t_{D_ret}	15	—	—	years

¹ Typical values are measured at 25 °C.

² t_{hv} is the cumulative high voltage programming time to the same row before next erase. Same address can not be programmed more than twice before next erase.

³ Fast V_{PP} rise time may potentially trigger the ESD protection structure, which may result in over current flowing into the pad and cause permanent damage to the pad. External filtering for the V_{PP} power source is recommended. An example V_{PP} filter is shown in Figure 17.

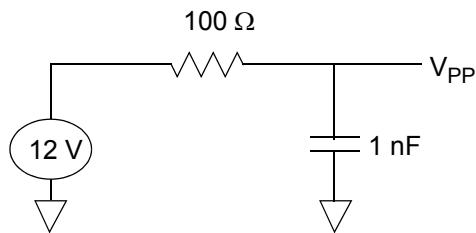
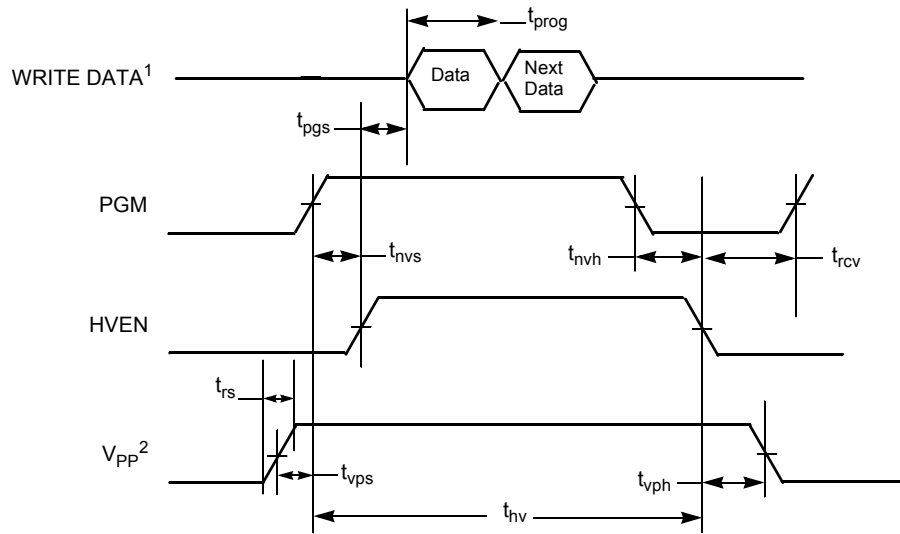
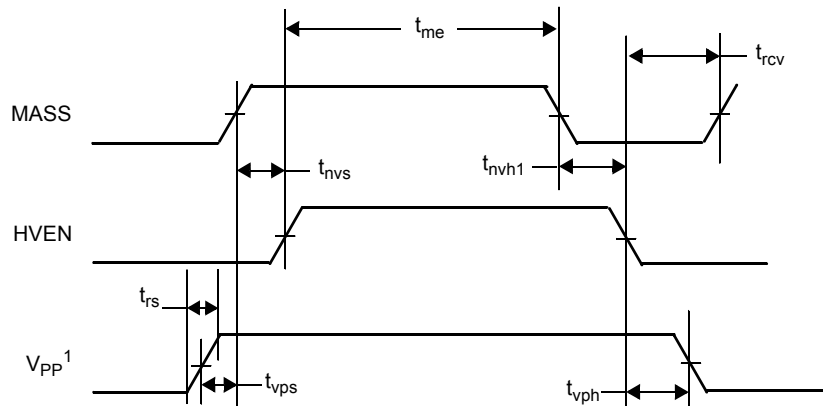


Figure 17. Example V_{PP} Filtering



- ¹ Next Data applies if programming multiple bytes in a single row, refer to *MC9RS08LA8 Series Reference Manual*.
- ² V_{DD} must be at a valid operating voltage before voltage is applied or removed from the V_{PP} pin.

Figure 18. Flash Program Timing

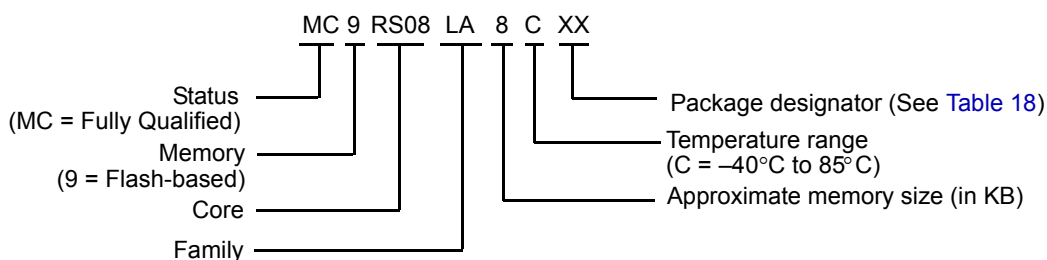


- ¹ V_{DD} must be at a valid operating voltage before voltage is applied or removed from the V_{PP} pin.

Figure 19. Flash Mass Erase Timing

4 Ordering Information

This section contains ordering information for MC9RS08LA8 devices. See below for an example of the device numbering system.



5 Package Information and Mechanical Drawings

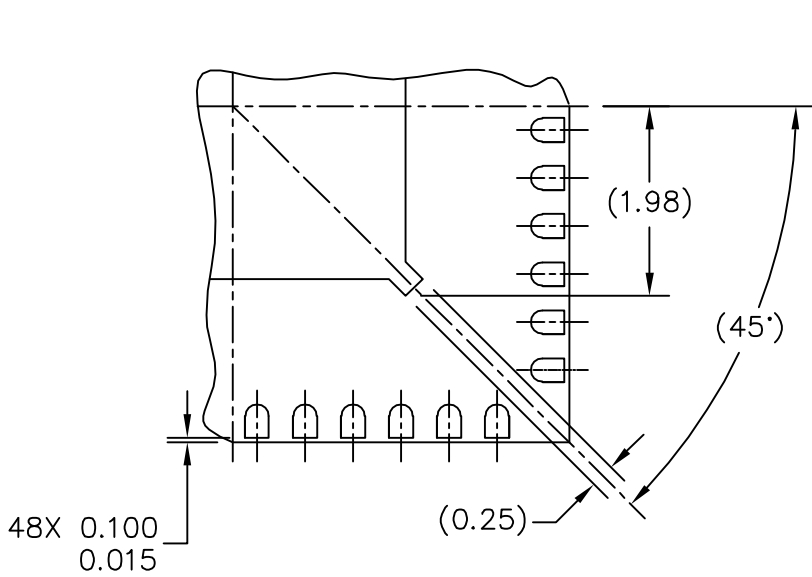
Table 18 provides the available package types and their document numbers. The latest package outline/mechanical drawings are available on the MC9RS08LA8 Series Product Summary pages at <http://www.freescale.com>.

To view the latest drawing, either:

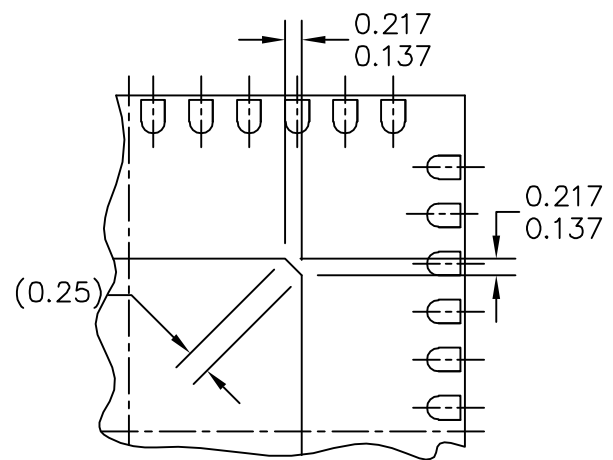
- Click on the appropriate link in Table 18, or
- Open a browser to the Freescale® website (<http://www.freescale.com>), and enter the appropriate document number (from Table 18) in the “Enter Keyword” search box at the top of the page.

Table 18. Device Numbering System

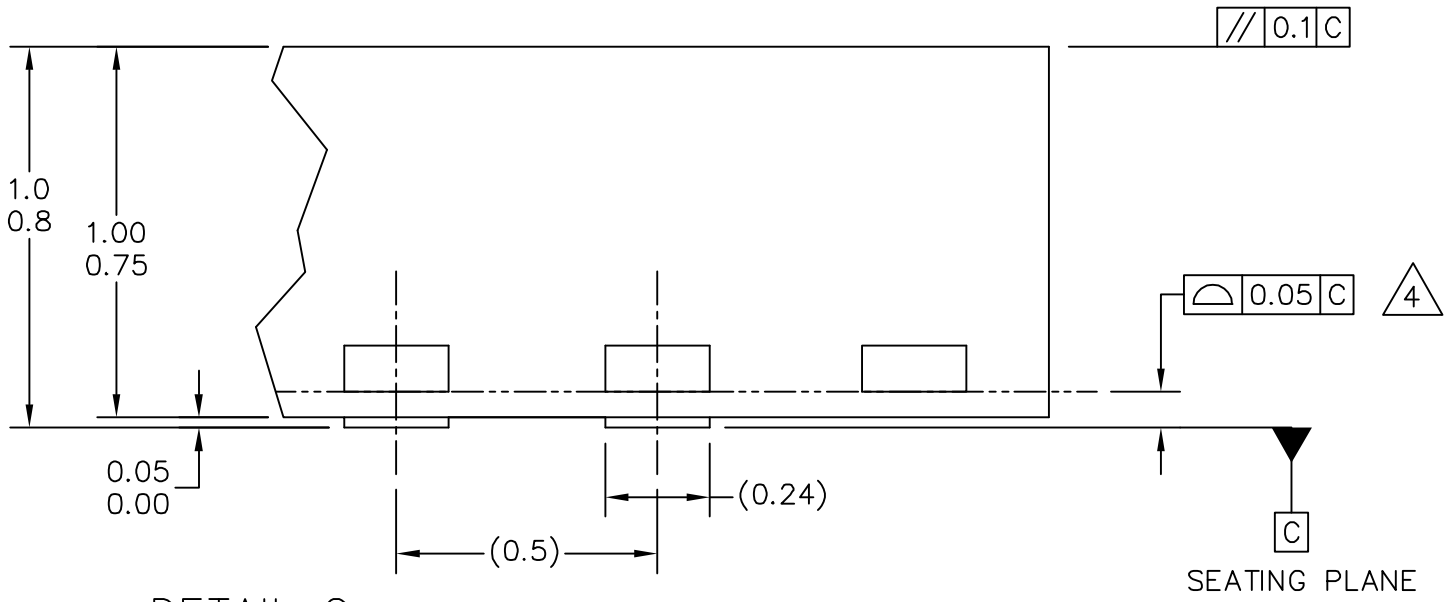
Device Number	Memory		Package		
	FLASH	RAM	Type	Designator	Document No.
MC9RS08LA8	8 KB	256 bytes	48-Pin QFN	FT	98ARL10606D
			48-Pin LQFP	LF	98ASH00962A



DETAIL N
PREFERRED CORNER CONFIGURATION



DETAIL M
PREFERRED PIN 1 BACKSIDE IDENTIFIER




DETAIL G
VIEW ROTATED 90° CW

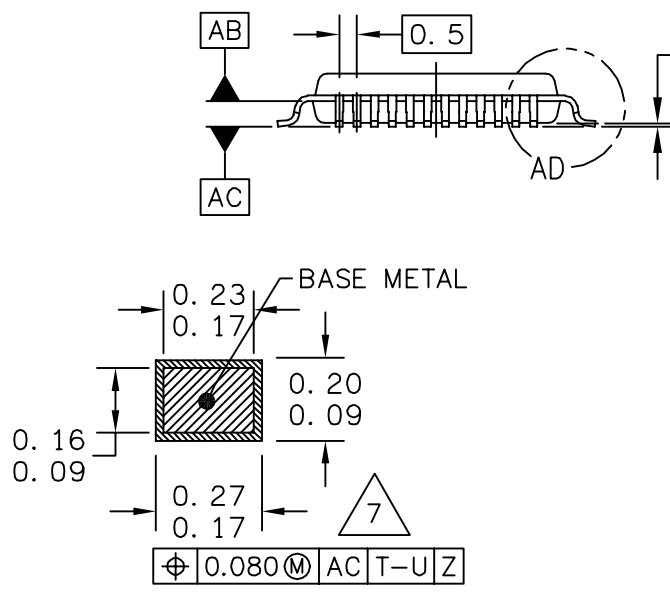
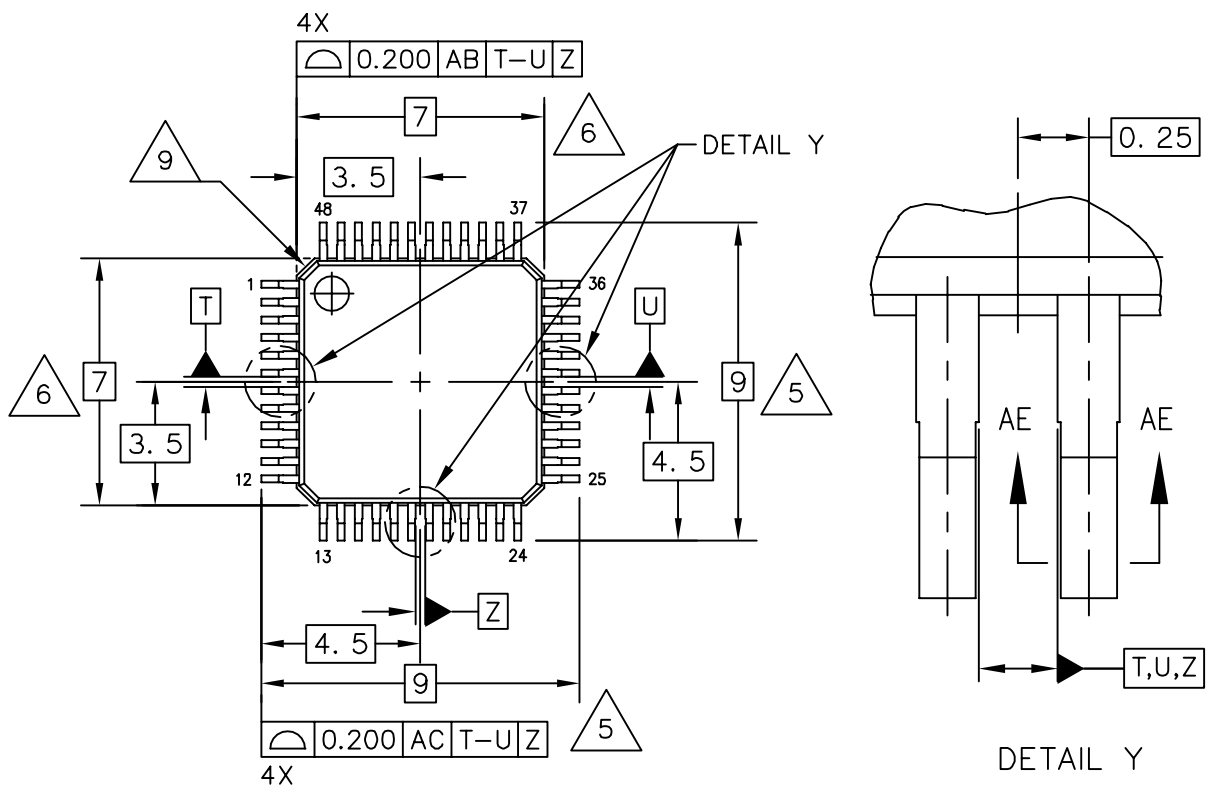
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TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 48 TERMINAL, 0.5 PITCH (7 X 7 X 1)	DOCUMENT NO: 98ARL10606D	REV: 0	
	CASE NUMBER: 1975-01	29 AUG 2007	
	STANDARD: JEDEC-MO-220 VKKD-2		



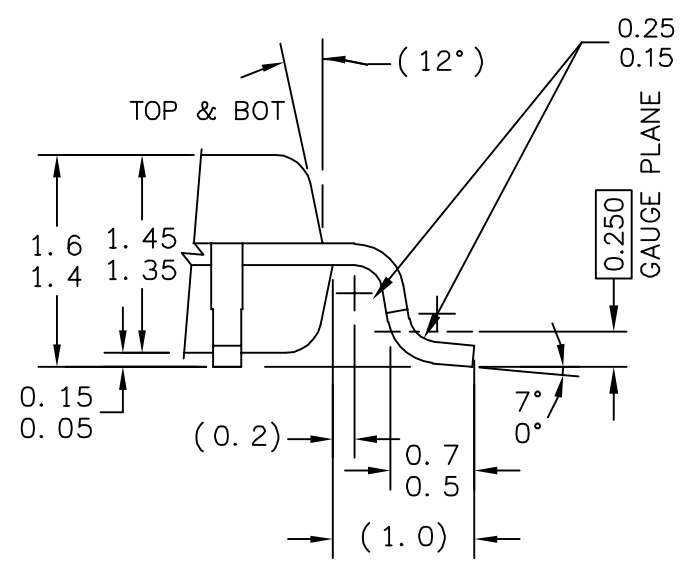
NOTES:

1. DIMENSIONS ARE IN MILLIMETERS.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. THE COMPLETE JEDEC DESIGNATOR FOR THIS PACKAGE IS: HF-PQFN.
4.  COPLANARITY APPLIES TO LEADS, CORNER LEADS, AND DIE ATTACH PAD.
5. MIN METAL GAP SHOULD BE 0.2MM.

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TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 48 TERMINAL, 0.5 PITCH (7 X 7 X 1)	DOCUMENT NO: 98ARL10606D	REV: 0	
	CASE NUMBER: 1975-01	29 AUG 2007	
	STANDARD: JEDEC-MO-220 VKKD-2		



SECTION AE-AE



DETAIL AD

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TITLE: LQFP, 48 LEAD, 0.50 PITCH (7.0 X 7.0 X 1.4)	DOCUMENT NO: 98ASH00962A	REV: G	
	CASE NUMBER: 932-03	14 APR 2005	
	STANDARD: JEDEC MS-026-BBC		



NOTES:

1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DATUM PLANE AB IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
4. DATUMS T, U, AND Z TO BE DETERMINED AT DATUM PLANE AB.



5. DIMENSIONS TO BE DETERMINED AT SEATING PLANE AC.



6. DIMENSIONS DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.250 PER SIDE. DIMENSIONS DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE AB.



7. THIS DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED 0.350.

8. MINIMUM SOLDER PLATE THICKNESS SHALL BE 0.0076.



9. EXACT SHAPE OF EACH CORNER IS OPTIONAL.

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TITLE: LQFP, 48 LEAD, 0.50 PITCH (7.0 X 7.0 X 1.4)	DOCUMENT NO: 98ASH00962A	REV: G	
	CASE NUMBER: 932-03	14 APR 2005	
	STANDARD: JEDEC MS-026-BBC		

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